



Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China

FDY4001CZ**Complementary N & P-Channel PowerTrench®
MOSFET****Features**

Q1: N-Channel

- Max $r_{DS(on)} = 5\Omega$ at $V_{GS} = 4.5V$, $I_D = 200mA$
- Max $r_{DS(on)} = 7\Omega$ at $V_{GS} = 2.5V$, $I_D = 175mA$
- Max $r_{DS(on)} = 9\Omega$ at $V_{GS} = 1.8V$, $I_D = 150mA$

Q2: P-Channel

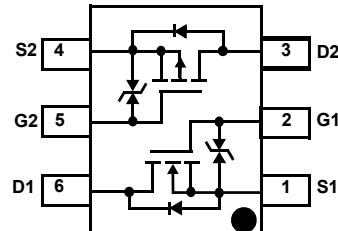
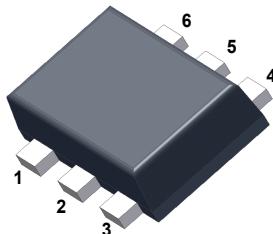
- Max $r_{DS(on)} = 8\Omega$ at $V_{GS} = -4.5V$, $I_D = -150mA$
- Max $r_{DS(on)} = 12\Omega$ at $V_{GS} = -2.5V$, $I_D = -125mA$
- Max $r_{DS(on)} = 15\Omega$ at $V_{GS} = -1.8V$, $I_D = -100mA$
- ESD protection diode (note 3)
- RoHS Compliant

**General Description**

This Complementary N & P-Channel MOSFET has been designed using Fairchild Semiconductor's advanced Power Trench® process to optimize the $r_{DS(ON)}$ @ $V_{GS}=2.5V$ and specify the $r_{DS(ON)}$ @ $V_{GS} = 1.8V$.

Applications

- Level shifting
- Power Supply Converter Circuits
- Load/Power Switching Cell Phones, Pagers

**MOSFET Maximum Ratings** $T_C = 25^\circ C$ unless otherwise noted

| Symbol | Parameter | Q1 | Q2 | Units |
|----------------|--|------------|---------|-------|
| V_{DS} | Drain to Source Voltage | 20 | -20 | V |
| V_{GS} | Gate to Source Voltage | ± 12 | ± 8 | V |
| I_D | Drain Current -Continuous (Note 1a) | 200 | -150 | mA |
| | -Pulsed | 1000 | -1000 | |
| P_D | Power Dissipation (Steady State) (Note 1a) | 625 | | mW |
| | (Note 1b) | 446 | | |
| T_J, T_{STG} | Operating and Storage Junction Temperature Range | -55 to 150 | | °C |

Thermal Characteristics

| | | | |
|-----------------|--|-----|------|
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient (Note 1a) | 200 | °C/W |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient (Note 1b) | 280 | |

Package Marking and Ordering Information

| Device Marking | Device | Package | Reel Size | Tape Width | Quantity |
|----------------|-----------|---------|-----------|------------|-----------|
| F | FDY4001CZ | SC89-6 | 7" | 8mm | 3000units |

Electrical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

| Symbol | Parameter | Test Conditions | Type | Min | Typ | Max | Units |
|-----------------------------------|---|---|----------------|-----------|-----------|---------------------------------|----------------------------|
| Off Characteristics | | | | | | | |
| B_{VDSS} | Drain to Source Breakdown Voltage | $I_D = 250\mu\text{A}, V_{GS} = 0\text{V}$ $I_D = -250\mu\text{A}, V_{GS} = 0\text{V}$ | Q1 Q2 | 20 -20 | | | V |
| ΔB_{VDSS} ΔT_J | Breakdown Voltage Temperature Coefficient | $I_D = 250\mu\text{A}, \text{referenced to } 25^\circ\text{C}$ $I_D = -250\mu\text{A}, \text{referenced to } 25^\circ\text{C}$ | Q1 Q2 | | 14 -15 | | $\text{mV/}^\circ\text{C}$ |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = 16\text{V}, V_{GS} = 0\text{V}$ $V_{DS} = -16\text{V}, V_{GS} = 0\text{V}$ | Q1 Q2 | | | 1 -3 | μA |
| I_{GSS} | Gate-Body Leakage | $V_{GS} = \pm 12\text{V}, V_{DS} = 0\text{V}$ $V_{GS} = \pm 4.5\text{V}, V_{DS} = 0\text{V}$ $V_{GS} = \pm 8\text{V}, V_{DS} = 0\text{V}$ | Q1 Q1 Q2 | | | ± 10 ± 1 ± 10 | μA |

On Characteristics (note 2)

| | | | | | | | |
|---|--|--|----------|--------------|------------|---------------------------|----------------------------|
| $V_{GS(\text{th})}$ | Gate to Source Threshold Voltage | $V_{GS} = V_{DS}, I_D = 250\mu\text{A}$ $V_{GS} = V_{DS}, I_D = -250\mu\text{A}$ | Q1 Q2 | 0.6 -0.65 | -1.0 | 1.5 -1.5 | V |
| $\frac{\Delta V_{GS(\text{th})}}{\Delta T_J}$ | Gate to Source Threshold Voltage Temperature Coefficient | $I_D = 250\mu\text{A}, \text{referenced to } 25^\circ\text{C}$ $I_D = -250\mu\text{A}, \text{referenced to } 25^\circ\text{C}$ | Q1 Q2 | | 2.8 -3 | | $\text{mV/}^\circ\text{C}$ |
| $r_{DS(\text{on})}$ | Drain to Source On Resistance | $V_{GS} = 4.5\text{V}, I_D = 200\text{mA}$ $V_{GS} = 2.5\text{V}, I_D = 175\text{mA}$ $V_{GS} = 1.8\text{V}, I_D = 150\text{mA}$ $V_{GS} = 1.5\text{V}, I_D = 20\text{mA}$ $V_{GS} = 4.5\text{V}, I_D = 200\text{mA}, T_J = 125^\circ\text{C}$ | Q1 | | | 5 7 9 10 7 | Ω |
| | | $V_{GS} = -4.5\text{V}, I_D = -150\text{mA}$ $V_{GS} = -2.5\text{V}, I_D = -125\text{mA}$ $V_{GS} = -1.8\text{V}, I_D = -100\text{mA}$ $V_{GS} = -1.5\text{V}, I_D = -30\text{mA}$ $V_{GS} = -4.5\text{V}, I_D = -150\text{mA}, T_J = 125^\circ\text{C}$ | | Q2 | | 8 12 15 20 12 | |
| g_{FS} | Forward Transconductance | $V_{DS} = 5\text{V}, I_D = 200\text{mA}$ $V_{DS} = -5\text{V}, I_D = -150\text{mA}$ | Q1 Q2 | | 1.1 0.7 | | S |

Dynamic Characteristics

| | | | | | | | |
|-----------|------------------------------|---|----------|--|-----------|--|----|
| C_{iss} | Input Capacitance | Q1 $V_{DS} = 10\text{V}, V_{GS} = 0\text{V}, f = 1\text{MHz}$ | Q1 Q2 | | 60 100 | | pF |
| C_{oss} | Output Capacitance | Q2 $V_{DS} = -10\text{V}, V_{GS} = 0\text{V}, f = 1\text{MHz}$ | Q1 Q2 | | 20 30 | | pF |
| C_{rss} | Reverse Transfer Capacitance | | Q1 Q2 | | 10 15 | | pF |

Switching Characteristics

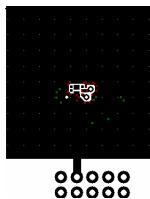
| | | | | | | | |
|--------------|-------------------------------|--|----------|--|-------------|------------|----|
| $t_{d(on)}$ | Turn-On Delay Time | Q1 $V_{DD} = 10\text{V}, I_D = 1\text{A}, V_{GS} = 4.5\text{V}, R_g = 6\Omega$ | Q1 Q2 | | 6 6 | 12 12 | ns |
| t_r | Rise Time | Q2 $V_{DD} = -10\text{V}, I_D = -0.5\text{A}, V_{GS} = -4.5\text{V}, R_g = 6\Omega$ | Q1 Q2 | | 8 13 | 16 23 | ns |
| $t_{d(off)}$ | Turn-Off Delay Time | Q2 $V_{DD} = -10\text{V}, I_D = -0.5\text{A}, V_{GS} = -4.5\text{V}, R_g = 6\Omega$ | Q1 Q2 | | 8 8 | 16 16 | ns |
| t_f | Fall Time | | Q1 Q2 | | 2.4 1 | 4.8 2 | ns |
| Q_g | Total Gate Charge | Q1 $V_{DS} = 10\text{V}, I_D = 200\text{mA}, V_{GS} = 4.5\text{V}$ | Q1 Q2 | | 0.8 1.0 | 1.1 1.4 | nC |
| Q_{gs} | Gate to Source Gate Charge | Q2 $V_{DS} = -10\text{V}, I_D = -150\text{mA}, V_{GS} = -4.5\text{V}$ | Q1 Q2 | | 0.16 0.2 | | nC |
| Q_{gd} | Gate to Drain "Miller" Charge | | Q1 Q2 | | 0.26 0.3 | | nC |

Electrical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

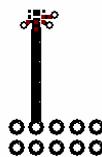
| Symbol | Parameter | Test Conditions | Type | Min | Typ | Max | Units |
|---|---------------------------------------|---|----------|-----|-------------|-------------|-------|
| Drain-Source Diode Characteristics | | | | | | | |
| V_{SD} | Source to Drain Diode Forward Voltage | $V_{GS} = 0V, I_S = 150\text{mA}$ (Note 2) $V_{GS} = 0V, I_S = -150\text{mA}$ (Note 2) | Q1 Q2 | | 0.7 -0.8 | 1.2 -1.2 | V |
| t_{rr} | Reverse Recovery Time | Q1 $I_F = 200\text{mA}, di/dt = 100\text{A}/\mu\text{s}$ | Q1 Q2 | | 12 11 | | ns |
| Q_{rr} | Reverse Recovery Charge | Q2 $I_F = -150\text{mA}, di/dt = 100\text{A}/\mu\text{s}$ | Q1 Q2 | | 3 2 | | nC |

Notes:

1: $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta JA}$ is determined by the user's board design.



a) $200^\circ\text{C}/\text{W}$ when mounted on a 1 in^2 pad of 2 oz copper



b) $280^\circ\text{C}/\text{W}$ when mounted on a minimum pad of 2 oz copper

Scale 1:1 on letter size paper

2: Pulse Test : Pulse Width < 300us, Duty Cycle < 2.0%

3: The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

Typical Characteristics Q1 (N-Channel)

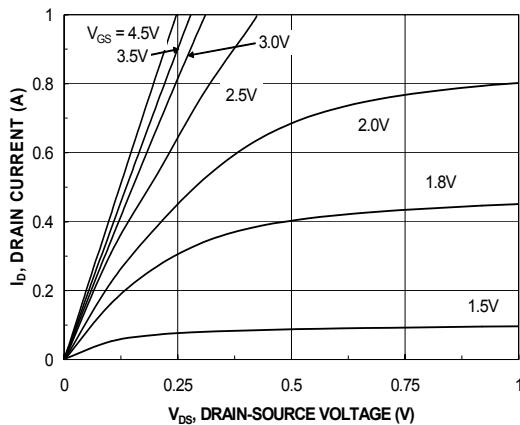


Figure 1. On-Region Characteristics.

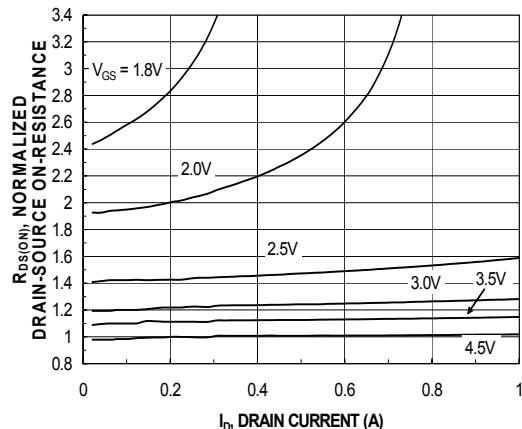


Figure 2. Normalized on-Resistance vs. Drain Current and Gate Voltage.

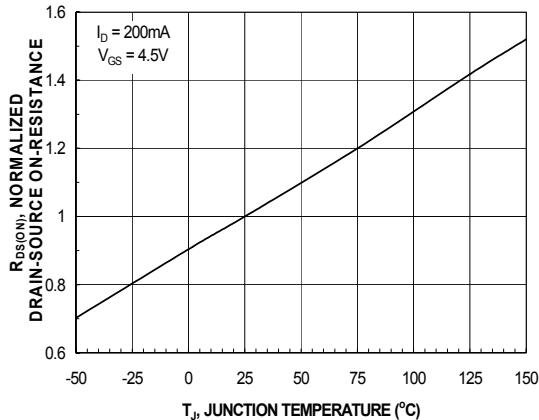


Figure 3. Normalized on-Resistance vs. Temperature.

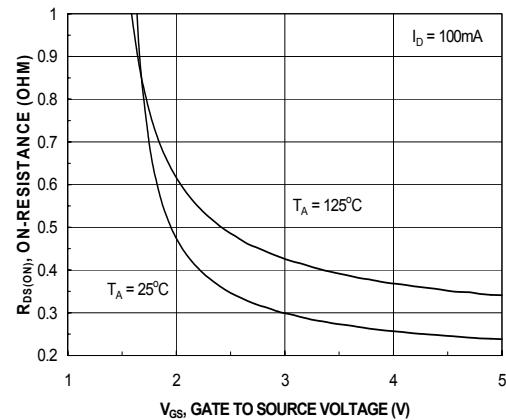


Figure 4. On-Resistance vs. Gate-to-Source Voltage.

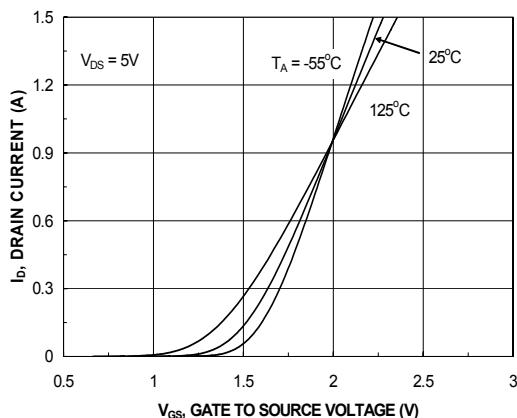


Figure 5. Transfer Characteristics.

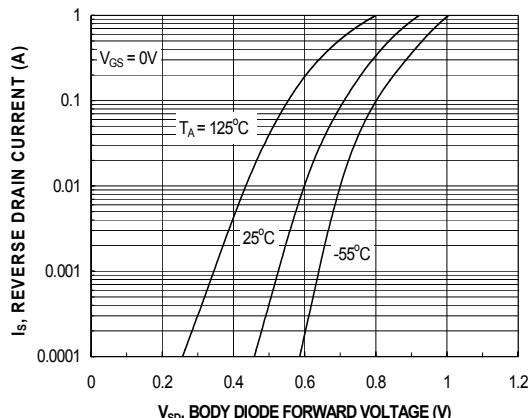


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current and Temperature.

Typical Characteristics Q1 (N-Channel)

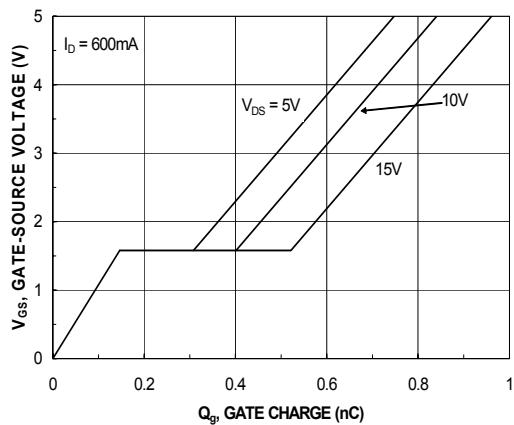


Figure 7. Gate Charge Characteristics.

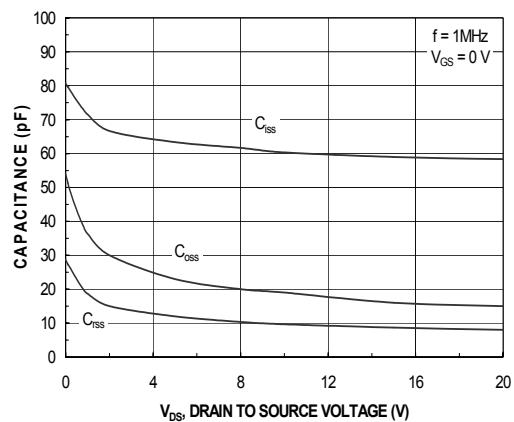


Figure 8. Capacitance vs. Drain to source voltage.

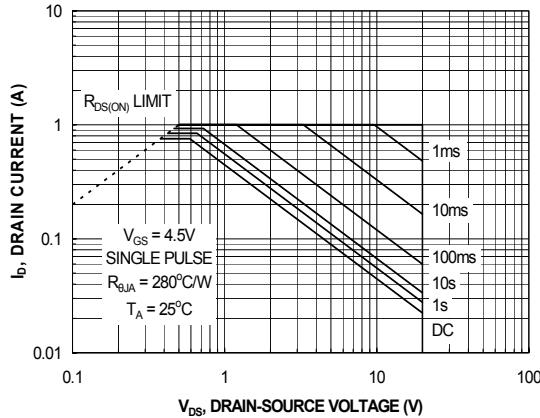


Figure 9. Maximum Safe Operating Area.

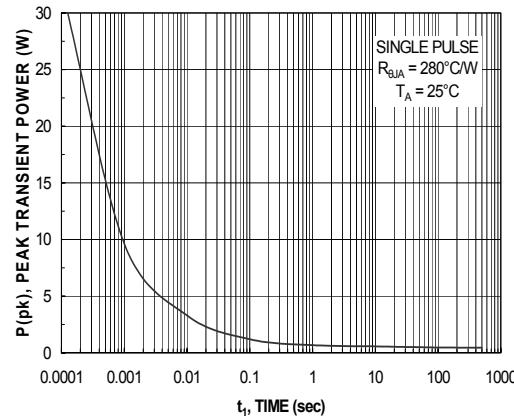


Figure 10. Single Pulse Maximum Power Dissipation.

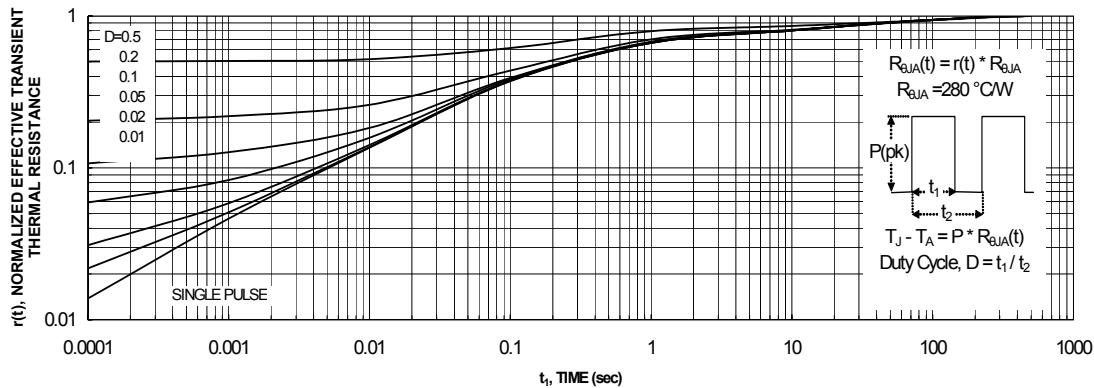


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b.
Transient thermal response will change depending on the circuit board design.

Typical Characteristics Q2 (P-Channel)

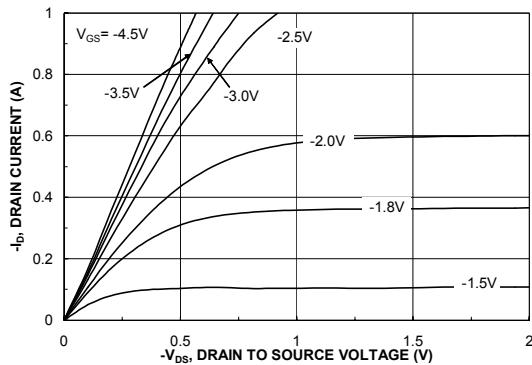


Figure 1. On-Region Characteristics.

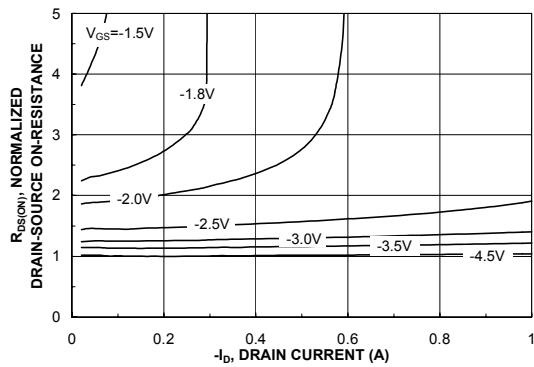


Figure 2. Normalized on-Resistance vs. Drain Current and Gate Voltage.

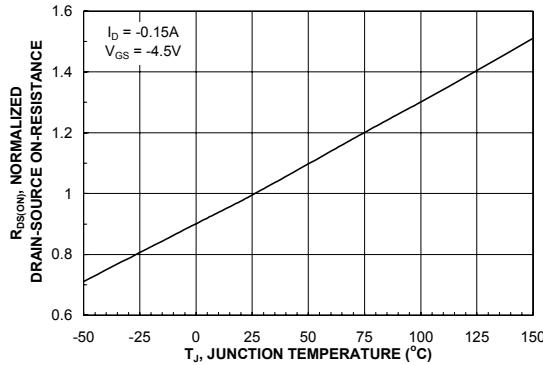


Figure 3. Normalized on-Resistance vs. Temperature.

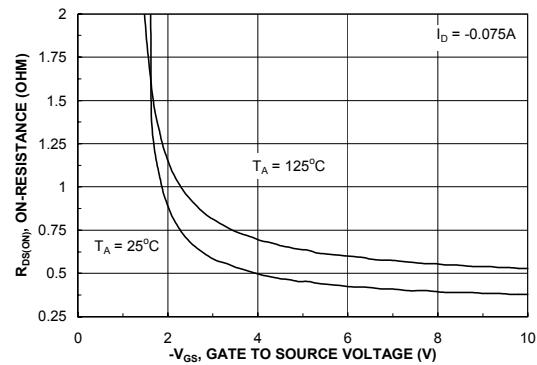


Figure 4. On-Resistance vs. Gate-to-Source Voltage.

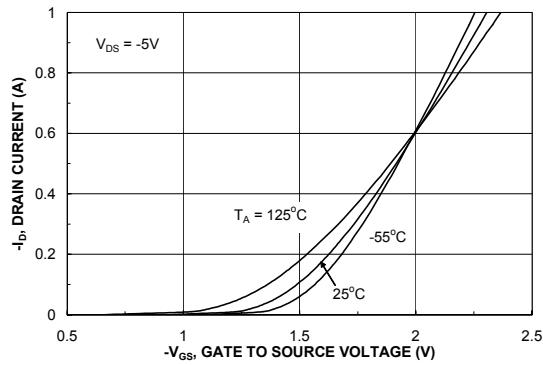


Figure 5. Transfer Characteristics.

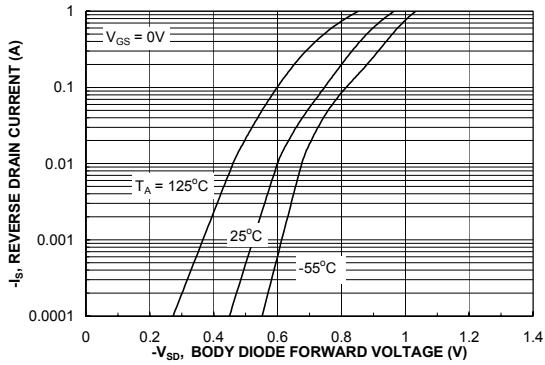


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current and Temperature.

Typical Characteristics Q2 (P-Channel)

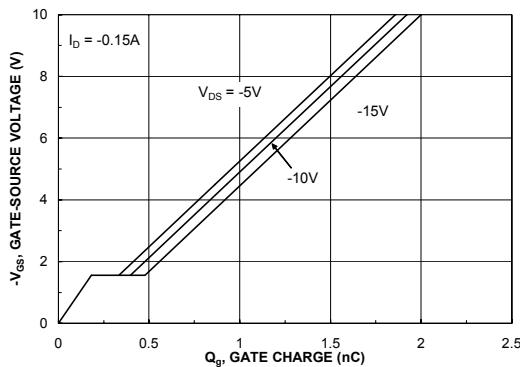


Figure 7. Gate Charge Characteristics.

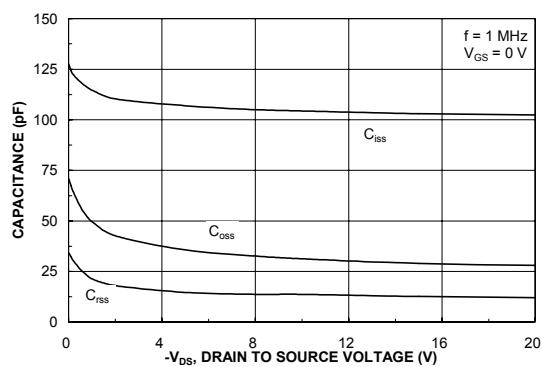


Figure 8. Capacitance vs. Drain to source voltage.

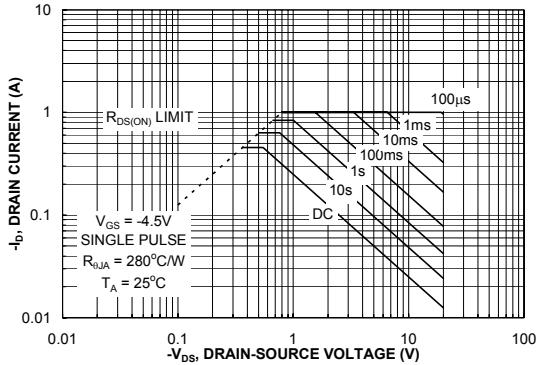


Figure 9. Maximum Safe Operating Area.

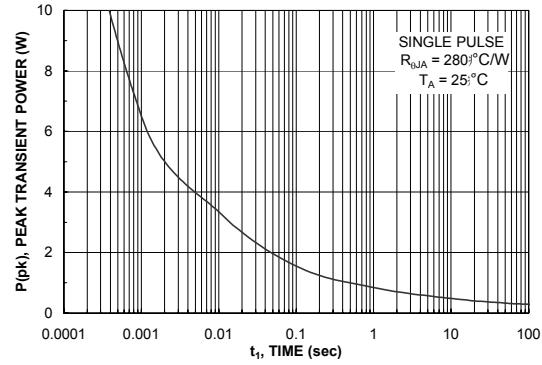


Figure 10. Single Pulse Maximum Power Dissipation.

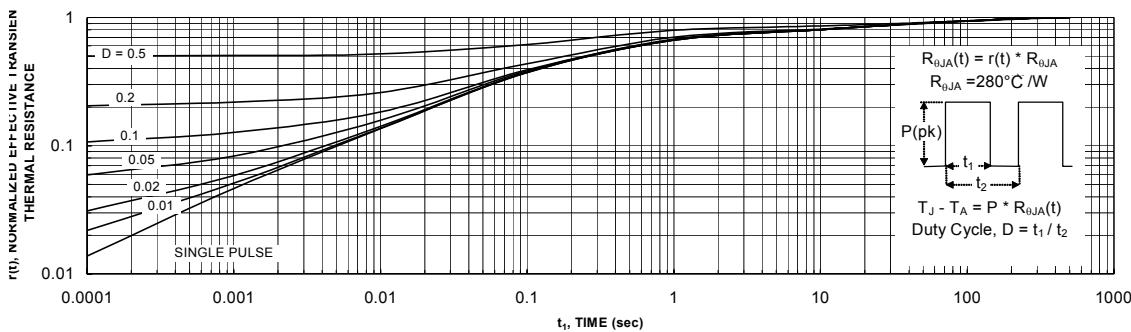
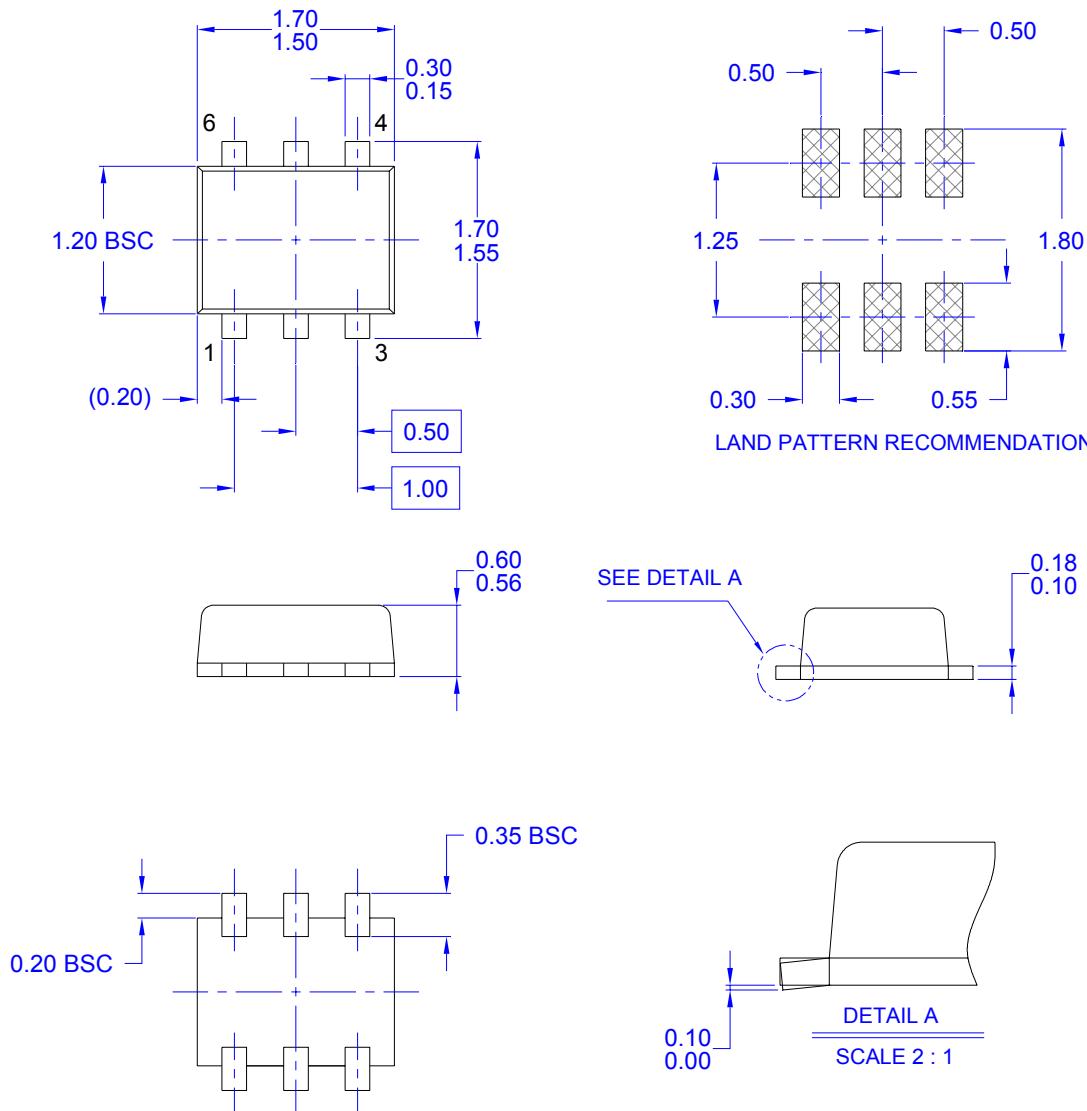


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

FDY4001CZ Complementary N & P-Channel PowerTrench® MOSFET

Dimensional Outline and Pad Layout



NOTES: UNLESS OTHERWISE SPECIFIED
A) THIS PACKAGE CONFORMS TO EIAJ SC89 PACKAGING STANDARD.

B) ALL DIMENSIONS ARE IN MILLIMETERS.

C) DIMENSIONS ARE EXCLUSIVE OF BURRS,
MOLD FLASH, AND TIE BAR EXTRUSIONS.

TRADEMARKS

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

| | | | | |
|--------------------------------------|---------------------|---------------------|------------------|-----------|
| ACEx™ | FACT Quiet Series™ | OCX™ | SILENT SWITCHER® | UniFET™ |
| ActiveArray™ | GlobalOptoisolator™ | OCXPro™ | SMART START™ | UltraFET® |
| Bottomless™ | GTO™ | OPTOLOGIC® | SPM™ | VCX™ |
| Build it Now™ | HiSeC™ | OPTOPLANAR™ | Stealth™ | Wire™ |
| CoolFET™ | I ² C™ | PACMAN™ | SuperFET™ | |
| CROSSVOLT™ | i-Lo™ | POP™ | SuperSOT™-3 | |
| DOME™ | ImpliedDisconnect™ | Power247™ | SuperSOT™-6 | |
| EcoSPARK™ | IntelliMAX™ | PowerEdge™ | SuperSOT™-8 | |
| E ² CMOS™ | ISOPLANAR™ | PowerSaver™ | SyncFET™ | |
| EnSigna™ | LittleFET™ | PowerTrench® | TCM™ | |
| FACT™ | MICROCOUPLER™ | QFET® | TinyBoost™ | |
| FAST® | MicroFET™ | QS™ | TinyBuck™ | |
| FASTR™ | MicroPak™ | QT Optoelectronics™ | TinyPWM™ | |
| FPS™ | MICROWIRE™ | Quiet Series™ | TinyPower™ | |
| FRFET™ | MSX™ | RapidConfigure™ | TinyLogic® | |
| | MSXPro™ | RapidConnect™ | TINYOPTO™ | |
| Across the board. Around the world.™ | | μSerDes™ | TruTranslation™ | |
| The Power Franchise® | | ScalarPump™ | UHC™ | |
| Programmable Active Droop™ | | | | |

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION, OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the user.
2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

PRODUCT STATUS DEFINITIONS

Definition of Terms

| Datasheet Identification | Product Status | Definition |
|--------------------------|------------------------|--|
| Advance Information | Formative or In Design | This datasheet contains the design specifications for product development. Specifications may change in any manner without notice. |
| Preliminary | First Production | This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design. |
| No Identification Needed | Full Production | This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design. |
| Obsolete | Not In Production | This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only. |